



Search Notes 	Application/Control No. 10705757	Applicant(s)/Patent Under Reexamination WEIHE ET AL.
	Examiner Dunston, Jennifer	Art Unit 1636

Notes	Date	Examiner
Updated PALM (Inventor), EAST, STN (search histories attached)	06/08/2006	JD
STIC Sequence Search (SEQ ID NOS: 2, 4 and 6, search histories attached)	06/08/2006	JD

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Class	SubClass	Date	Examiner
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